

N-Channel Power Trench[®] MOSFET 25 V, 5.8 m Ω

Features

- Max $r_{DS(on)}$ = 5.8 m Ω at V_{GS} = 10 V, I_D = 17 A
- Max $r_{DS(on)}$ = 8 m Ω at V_{GS} = 4.5 V, I_D = 14 A
- Advanced Package and Silicon combination for low r_{DS(on)} and high efficiency
- Next generation enhanced body diode technology, engineered for soft recovery
- MSL1 robust package design
- 100% UIL tested
- RoHS Compliant

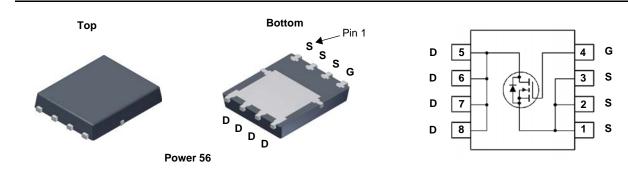


General Description

This N-Channel MOSFET has been designed specifically to improve the overall efficiency and to minimize switch node ringing of DC/DC converters using either synchronous or conventional switching PWM controllers. It has been optimized for low gate charge, low $r_{DS(on)}$, fast switching speed and body diode reverse recovery performance.

Applications

- Control MOSFET for Synchronous Buck Converters
- Notebook
- Server
- Telecomm
- High Efficiency DC-DC Switch Mode Power Supplies



MOSFET Maximum Ratings T_A = 25 °C unless otherwise noted

Symbol	Parameter			Ratings	Units	
V _{DS}	Drain to Source Voltage			25	V	
V _{GS}	Gate to Source Voltage		(Note 4)	±20	V	
ID	Drain Current -Continuous (Package limited)	T _C = 25 °C		28		
	-Continuous (Silicon limited)	T _C = 25 °C		63	^	
	-Continuous	T _A = 25 °C	(Note 1a)	17	Α	
	-Pulsed			60		
E _{AS}	Single Pulse Avalanche Energy (Note 3)			40	mJ	
P _D	Power Dissipation	T _C = 25 °C		33	14/	
	Power Dissipation $T_A = 25 \text{ °C}$ (Note 1a)		(Note 1a)	2.5	W	
T _J , T _{STG}	Operating and Storage Junction Temperature Range			-55 to +150	°C	

Thermal Characteristics

$R_{ ext{ heta}JC}$	Thermal Resistance, Junction to Case	3.7	°C/W]
$R_{ hetaJA}$	Thermal Resistance, Junction to Ambient (Note 1	a) 50	C/vv	

Package Marking and Ordering Information

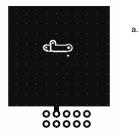
Device Marking	Device	Package	Reel Size	Tape Width	Quantity
FDMS0346	FDMS0346	Power 56	13 "	12 mm	3000 units

FDMS0346
N-Channel
Power T
rench [®]
MOSFET

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Symbol	Parameter	Test Con	ditions	Min	Тур	Max	Units
Off Chara	cteristics						
BV _{DSS}	Drain to Source Breakdown Voltage	I _D = 250 μA, V _{GS} = 0 V		25			V
$\frac{\Delta BV_{DSS}}{\Delta T_J}$	Breakdown Voltage Temperature Coefficient	$I_D = 250 \ \mu\text{A}$, referenced to 25 °C			20		mV/°C
IDSS	Zero Gate Voltage Drain Current	$V_{DS} = 20 V, V_{GS} = 0$	0 V			1	μA
I _{GSS}	Gate to Source Leakage Current, Forward	$V_{GS} = 20 \text{ V}, \text{ V}_{DS} = 0$	0 V			100	nA
On Chara	cteristics						
V _{GS(th)}	Gate to Source Threshold Voltage	$V_{GS} = V_{DS}, I_D = 25$	60 μΑ	1.0	1.6	3.0	V
$\frac{\Delta V_{GS(th)}}{\Delta T_J}$	Gate to Source Threshold Voltage Temperature Coefficient	$I_D = 250 \ \mu$ A, referen			-6		mV/°C
0		V _{GS} = 10 V, I _D = 17 A			4.6	5.8	
r _{DS(on)}	Static Drain to Source On Resistance	$V_{GS} = 4.5 \text{ V}, I_D = 14 \text{ A}$			6.3	8	mΩ
- (-)		$V_{GS} = 10 \text{ V}, I_D = 17$		6.7	8.5		
9 _{FS}	Forward Transconductance	V _{DD} = 5 V, I _D = 17 A			77		S
Dynamic C _{iss}	Characteristics Input Capacitance	V _{DS} = 13 V, V _{GS} = 0 V, f = 1 MHz			1221	1625	pF
C _{oss}	Output Capacitance				371	495	pF
C _{rss}	Reverse Transfer Capacitance				54	85	pF
Rg	Gate Resistance				1.2	2.4	Ω
Switching	Characteristics						
t _{d(on)}	Turn-On Delay Time				8	17	ns
t _r	Rise Time	$V_{\text{DD}} = 13 \text{ V}, \text{ I}_{\text{D}} = 17 \text{ A},$ $V_{\text{GS}} = 10 \text{ V}, \text{ R}_{\text{GEN}} = 6 \Omega$			2.6	10	ns
t _{d(off)}	Turn-Off Delay Time				20	33	ns
t _f	Fall Time	_			2.2	10	ns
0	Total Gate Charge	$V_{GS} = 0 V \text{ to } 10 V$			18	25	nC
Q _{g(TOT)}	Total Gate Charge	$V_{GS} = 0 V \text{ to } 4.5 V$	V _{DD} = 13 V		8	11	nC
Q _{gs}	Total Gate Charge	I _D = 17 A			3.7		nC
Q _{gd}	Gate to Drain "Miller" Charge				1.7		nC
Drain-Sou	Irce Diode Characteristics						
V _{SD}	Source to Drain Diado, Ferward Valtage	$V_{GS} = 0 V, I_{S} = 2 A$	(Note 2)		0.72	1.1	V
	Source to Drain Diode Forward Voltage	$V_{GS} = 0 \text{ V}, \text{ I}_{S} = 17 \text{ A}$			0.83	1.2	v
t _{rr}	Reverse Recovery Time	$l_{-} = 17 \text{ A di/dt} = 10$	0 A/us		20	32	ns
Q _{rr}	Reverse Recovery Charge	— I _F = 17 A, di/dt = 100 A/μs			6	12	nC
t _{rr}	Reverse Recovery Time	$l_{-} = 17 \text{ A} \text{ di/dt} = 30$	0 A/us		19	34	ns
Q _{rr}	Reverse Recovery Charge	— I _F = 17 A, di/dt = 300 A/μs			13	24	nC

R_{θJA} is determined with the device mounted on a 1 in² pad 2 oz copper pad on a 1.5 x 1.5 in. board of FR-4 material. R_{θJC} is guaranteed by design while R_{θCA} is determined by the user's board design.





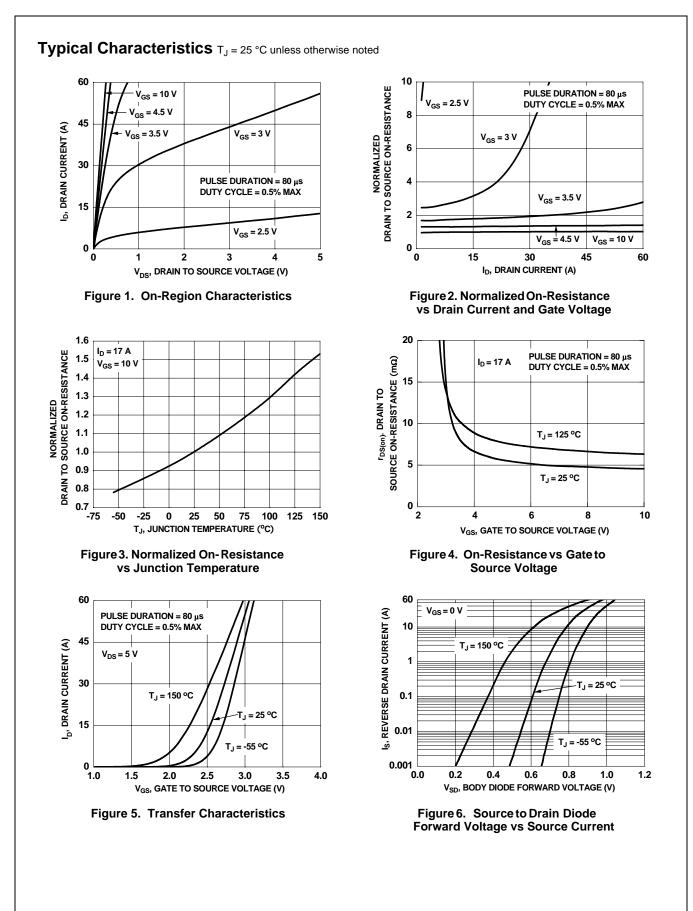
b.125 °C/W when mounted on a minimum pad of 2 oz copper



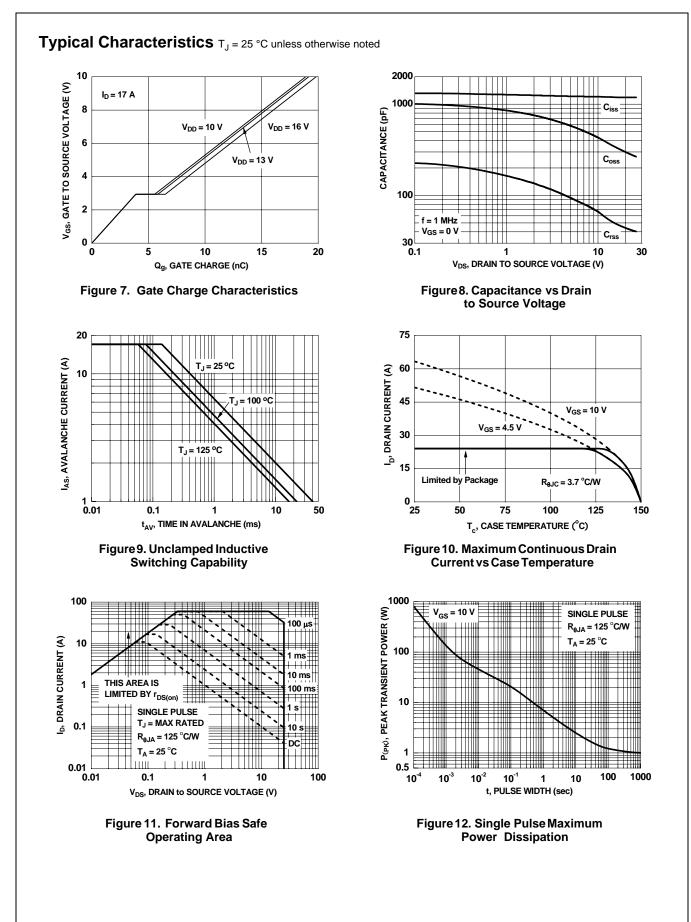
2. Pulse Test: Pulse Width < 300 $\mu s,$ Duty cycle < 2.0 %.

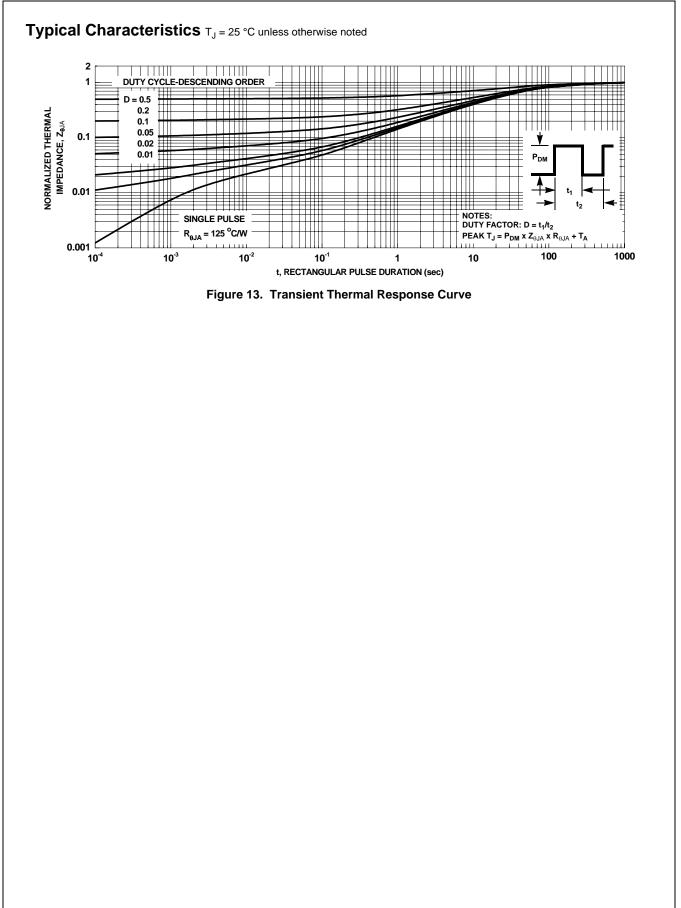
3. E_{AS} of 40 mJ is based on starting T_J = 25 °C, L = 1 mH, I_{AS} = 9 A, V_{DD} = 23 V, V_{GS} = 10 V. 100% test at L = 0.3 mH, I_{AS} = 14 A.

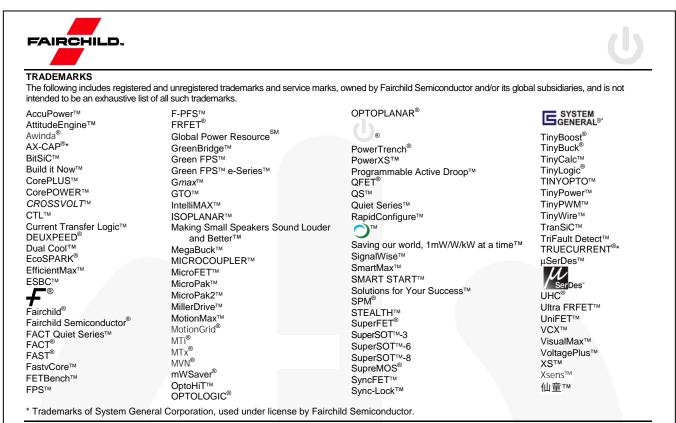
4. As an N-ch device, the negative Vgs rating is for low duty cycle pulse occurrence only. No continuous rating is implied.











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